TOSHIBA PHOTOCOUPLER PHOTO RELAY

TLP3215

MEASUREMENT INSTRUMENTS LOGIC IC TESTERS / MEMORY TESTERS BOARD TESTERS / SCANNERS

The TOSHIBA TLP3215 is a super small-outline photorelay, suitable for surface-mount assembly. The TLP3215 consists of a GaAs infrared-emitting diode optically coupled to a photo-MOS FET and housed in a 4-pin package.

The TLP3215 features low CR multiplication and especially low On-state resistance, allowing high ON-state current.

Its characteristics also include low OFF-state current and low output pin capacitance, enabling it to be used in high-frequency measuring instruments.

Features

• 4 pin SSOP (SSOP4) : 1.8 mm high, 1.27 mm pitch

• 1-Form-A

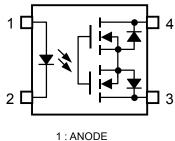
Peak Off-State Voltage : 40 V (MIN.)
 Trigger LED Current : 4 mA (MAX.)
 On-State Current : 300 mA (MAX.)

• On-State Resistance : 1.5Ω (MAX.), 1.0Ω (TYP.) • Output Capacitance : 14 pF (MAX.), 10 pF (TYP.)

• Isolation Voltage : 1500 Vrms (MIN.)

Weight: 0.03 g

Pin Configuration (top view)



2 : CATHODE 3 : DRAIN 4 : DRAIN

Absolute Maximum Ratings (Ta = 25°C)

	CHARACTERISTIC	SYMBOL	RATING	UNIT	
	Forward Current	lF	50	mA	
ED	Forward Current Derating (Ta ≧ 25°C)	ΔI _F /°C	-0.5	mA/°C	
"	Reverse Voltage	V_{R}	5	V	
	Junction Temperature	Tj	125	°C	
~	Off-State Output Terminal Voltage	V _{OFF}	40	V	
CTO	On-State Current	I _{ON}	300	mA	
DETECTOR	On-State Current Derating (Ta ≥ 25°C)	Δl _{ON} /°C	-3.0	mA/°C	
	Junction Temperature	Tj	125	°C	
Storage Temperature Range		T _{stg}	−40~125	°C	
Operating Temperature Range		T _{opr}	-20~85	°C	
Lead	Lead Soldering Temperature (10 s)		260	°C	
Isolat	tion Voltage (AC, 1 minute, R.H. \leq 60%) (NOTE1)	BVS	1500	Vrms	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

(NOTE1): Device considered a two-terminal device: Pins 1 and, 2 shorted together, and pins 3 and 4 shorted together.

Caution

This device is sensitive to electrostatic discharge. When using this device, please ensure that all tools and equipment are earthed.

This device is applying super small package which is free for Moisture-Proof packing. However, the application of this device is premised on use under controlled environmental condition like as measuring instrument. It is necessary to take precautions of storage condition and operating environmental condition.

Recommended Operating Conditions

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT
Supply Voltage	V_{DD}	_	_	32	V
Forward Current	lF	10	_	30	mA
On-State Current	I _{ON}	_	_	300	mA
Operating Temperature	T _{opr}	25	_	60	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Individual Electrical Characteristics (Ta = 25°C)

	CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
	Forward Voltage	V _F	I _F = 10 mA	1.0	1.15	1.3	V
ЕÐ	Reverse Current	I _R	V _R = 5 V			10	μА
	Capacitance	C _T	V = 0, f = 1 MHz	_	15	_	pF
CTOR	Off-State Current	l _{OFF}	V _{OFF} = 30 V, Ta = 50°C	_	_	1000	pА
DETEC.	Capacitance	C _{OFF}	V = 0, f = 100 MHz, t < 1 s		10	14	pF

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Coupled Electrical Characteristics (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Trigger LED Current	I _{FT}	I _{ON} = 100 mA	_	_	4	mA
Return LED Current	I _{FC}	I _{OFF} = 10 μA	0.2	0.75	_	mA
On-State Resistance	R _{ON}	$I_{ON} = 300 \text{ mA}, I_F = 5 \text{ mA}, t < 1 \text{ s}$	_	1.0	1.5	Ω

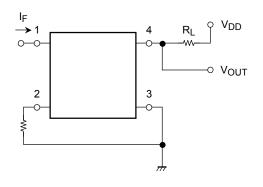
Isolation Characteristics (Ta = 25°C)

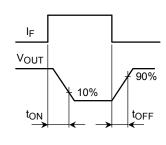
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Capacitance Input to Output	Cs	V _S = 0 V, f = 1 MHz	_	0.3	_	pF
Isolation Resistance	R _S	V _S = 500 V, R.H. ≦ 60%	5 × 10 ¹⁰	10 ¹⁴	_	Ω
Isolation Voltage	BVS	AC, 1 minute	1500	_	_	Vrms
		AC, 1 second (in oil)	_	3000	_	VIIIIS
		DC, 1 minute (in oil)	_	3000	_	Vdc

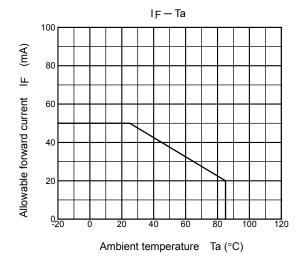
Switching Characteristics (Ta = 25°C)

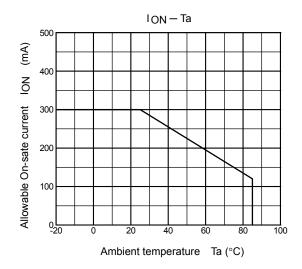
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Turn-on Time	t _{ON}	$R_L = 200 \Omega$ (NOTE	4) —	200	500	6
Turn-off Time	tOFF	$V_{DD} = 10 \text{ V}, I_F = 5 \text{ mA}$	_	200	500	μS

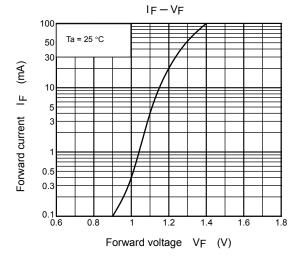
(NOTE 4): SWITCHING TIME TEST CIRCUIT

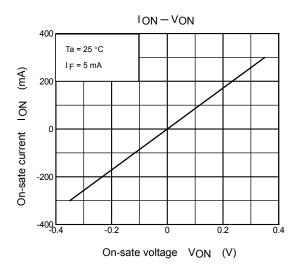


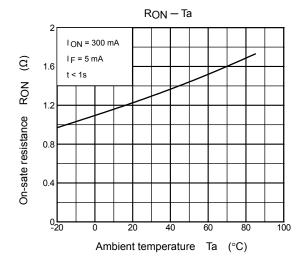


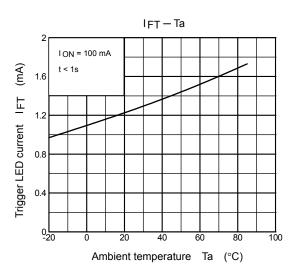


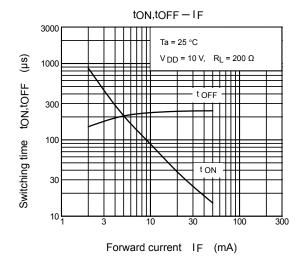


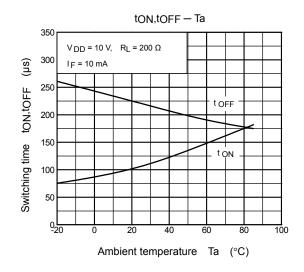


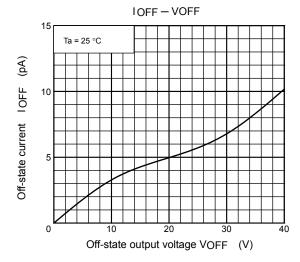


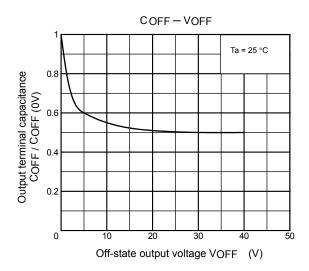






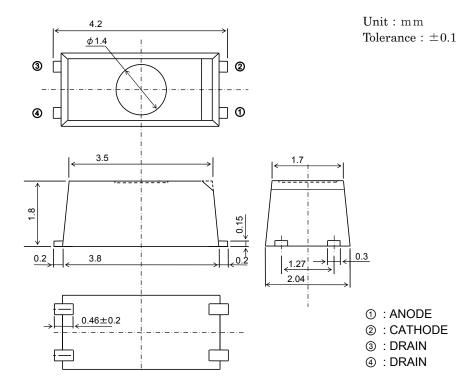






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OUTLINE DRAWING



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